

Search Notes**Application/Control No.**

10/542,644

Examiner

THANH LAM

**Applicant(s)/Patent under
Reexamination**

HOFFMANN ET AL.

Art Unit

2834

SEARCHED

Class	Subclass	Date	Examiner
310	12,179- 184	11/6/2008	TL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR